



	TEST REPO	ORT				
FCC ID	2APP6ARU-10					
Test Report No:	TCT240104E038					
Date of issue:	Mar. 26, 2025	$\left(\mathcal{C} \right)$	(\mathcal{G})			
Testing laboratory:	SHENZHEN TONGCE TES	STING LAB				
Testing location/ address:	101 & 2201, Zhenchang Factory, Renshan Industrial Zone, uhai Subdistrict, Bao'an District, Shenzhen, Guangdong, 18103, People's Republic of China					
Applicant's name:	Aroma Music Co., Ltd.	oma Music Co., Ltd.				
Address:	203, No. 93 Qianjin 2nd Ro Xixiang Town, Baoan Distr 518000 China	203, No. 93 Qianjin 2nd Road, Area 81, Hexi Neighbourhood, Kixiang Town, Baoan District, Shenzhen City, Guangdong, 518000 China				
Manufacturer's name :	Aroma Technology Co., Lir	nited				
Address:	Building A, Aroma Park, Gu District, Huizhou, Guangdo	uwu Village, D ng 516200 Ch	anshui Town, Huiyang iina			
Standard(s):	FCC CFR Title 47 Part 15	Subpart C Sec	tion 15.236			
Product Name:	WIRELESS AUDIO TRANS	SMISSION				
Trade Mark:	N/A	$\langle \mathcal{C} \rangle$	$\left(\mathcal{C}^{\prime}\right)$			
Model/Type reference :	ARU-10, AirMate II , IN-80, EKGBUHF	BRU-10, ARC	2, VoxMate, M4, BRC2,			
Rating(s):	Rechargeable Li-ion Batter	y DC 3.7V				
Date of receipt of test item	Jan. 04, 2025	×				
Date (s) of performance of test:	Jan. 04, 2025 ~ Mar. 26, 20	025				
Tested by (+signature) :	Ronaldo LUO	× Rona	Ild - TABY GCE 7			
Check by (+signature) :	Beryl ZHAO	Barge	水 で (TCT) ま			
Approved by (+signature):	Tomsin	Tom	Sim 23 3			
General disclaimer:			· · ·			

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1. General Product Information

1.1. EUT description

(\mathcal{G})		(,G')		$(\mathcal{L}\mathcal{G})$		
Product Name:	WIRELE	SS AUDIO TR	ANSMISSIC	ON		e e
Model/Type reference:	ARU-10					
Sample Number:	TCT2401	104E038-0101				
Operation Frequency:	657.1MH	lz-662.9MHz				
Modulation Technology:	FSK					G
Antenna Type:	Internal A	Antenna				S.
Antenna Gain:	-3.75dBi					
Rating(s):	Recharge	eable Li-ion Ba	ttery DC 3.	7V	$\langle \mathcal{O} \rangle$	

Note: The antenna gain listed in this report is provided by applicant, and the test laboratory is not responsible for this parameter.

1.2. Model(s) list

1.2. Mode	I(s) list	
No.	Model No.	Tested with
1	ARU-10	\square
Other models	AirMate II, IN-80, BRU-10, ARC2, VoxMate, M4, EKGBUHF	BRC2,

Note: ARU-10 is tested model, other models are derivative models. The models are identical in circuit and PCB layout, only different on the model names and timbre processing circuit. So the test data of ARU-10 can represent the remaining models.

1.3. Operation Frequency

657.1MHz-662.9MHz

Channel	Frequency	Channel	Frequency	Channel	Frequency	Channel	Frequency
1	657.1MHz	3	658.7MHz	5	660.3MHz	7	662.9MHz
2	657.9MHz	4	659.5MHz	6	661.1MHz		
Remark: (Channel 1. 4	& 7 have	been tested	for FSK n	nodulation m	ode.	(

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2. General Information

2.1. Test environment and mode

Operating Environment:

Condition	Conducted Emission	Radiated Emission
Temperature:	23.5 °C	23.7 °C
Humidity:	52 % RH	54 % RH
Atmospheric Pressure:	1010 mbar	1010 mbar

Test Mode:

Engineering mode: Keep the EUT in continuous transmitting by select channel and modulations with Fully-charged battery

The sample was placed 0.8m & 1.5m for the measurement below & above 1GHz above the ground plane of 3m chamber. Measurements in both horizontal and vertical polarities were performed. During the test, each emission was maximized by: having the EUT continuously working, investigated all operating modes, rotated about all 3 axis (X, Y & Z) and considered typical configuration to obtain worst position, manipulating interconnecting cables, rotating the turntable, varying antenna height from 1m to 4m in both horizontal and vertical polarizations. The emissions worst-case(Z axis) are shown in Test Results of the following pages.

2.2. Description of Support Units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Equipment	Model No.	Serial No.	FCC ID	Trade Name
Adapter	JD-050200	2012010907576735	/	JD

Note:

1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.

2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

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3. Facilities and Accreditations

CT 通测检测 TESTING CENTRE TECHNOLOGY

3.1. Facilities

The test facility is recognized, certified, or accredited by the following organizations:

 FCC - Registration No.: 645098
 SHENZHEN TONGCE TESTING LAB Designation Number: CN1205

The testing lab has been registered and fully described in a report with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files.

 IC - Registration No.: 10668A-1 SHENZHEN TONGCE TESTING LAB CAB identifier: CN0031

The testing lab has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing.

3.2. Location

SHENZHEN TONGCE TESTING LAB

Address: 2101 & 2201, Zhenchang Factory Renshan Industrial Zone, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, 518103, People's Republic of China TEL: +86-755-27673339

3.3. Measurement Uncertainty

The reported uncertainty of measurement $y \pm U$, where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95 %.

	No.	Item	MU	Ĉ
	1	Conducted Emission	± 3.10 dB	
	2	RF power, conducted	± 0.12 dB	
	3	Spurious emissions, conducted	± 0.11 dB	
	4	All emissions, radiated(<1 GHz)	± 4.56 dB	
2	5	All emissions, radiated(1 GHz - 18 GHz)	± 4.22 dB	
)	6	All emissions, radiated(18 GHz- 40 GHz)	± 4.36 dB	KC



2. Conducted Emiss	ion					
Test Requirement:	FCC Part15 C Section	15.207				
Test Method:	ANSI C63.10:2013	$\langle \mathcal{O}^{(1)} \rangle$	(\mathcal{C})			
Frequency Range:	150 kHz to 30 MHz					
Receiver setup:	RBW=9 kHz, VBW=30) kHz, Sweep time	=auto			
_imits:	Frequency range (MHz) 0.15-0.5 0.5-5 5-30	Limit (c Quasi-peak 66 to 56* 56 60	dBuV) Average 56 to 46* 46 50			
Гest Setup:	40cm E.U.T AC powe Test table/Insulation plane Remarkc E.U.T: Equipment Under Test LISN: Line Impedence Stabilization N Test table height=0.8m	80cm Filter EMI Receiver	— AC power			
Test Mode:	Charging + transmittin	g modulation				
Test Procedure:	 The E.U.T is connelline impedance stands provides a 500hm/s measuring equipme The peripheral device power through a Licoupling impedance refer to the block photographs). Both sides of A.C. conducted interferent emission, the relative the interface cables ANSI C63.10: 2013 	 Charging + transmitting modulation 1. The E.U.T is connected to the main power through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm/50uH coupling impedance for the measuring equipment. 2. The peripheral devices are also connected to the main power through a LISN that provides a 50ohm/50uH coupling impedance with 50ohm termination. (Please refer to the block diagram of the test setup and photographs). 3. Both sides of A.C. line are checked for maximum conducted interference. In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed according to 				

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4.2.2. Test Instruments

Cond	Conducted Emission Shielding Room Test Site (843)									
Equipment	Manufacturer	Model	Serial Number	Calibration Due						
EMI Test Receiver	R&S	ESCI3	100898	Jun. 29, 2024						
Line Impedance Stabilisation Newtork(LISN)	Schwarzbeck	NSLK 8126	8126453	Jan. 31, 2025						
Line-5	тст	CE-05	1 (6	Jul. 03, 2024						
EMI Test Software	Shurple Technology	EZ-EMC	1	1						

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Note:

12

Freq. = Emission frequency in MHz

Reading level $(dB\mu V)$ = Receiver reading Corr. Factor (dB) = LISN factor + Cable loss

19.93

 $M_{\text{apply}} = E \text{ for factor } \text{ for a local (dB)}$

Measurement ($dB\mu V$) = Reading level ($dB\mu V$) + Corr. Factor (dB)

10.16

30.09

 $Limit (dB\mu V) = Limit stated in standard$

Margin (dB) = Measurement (dB μ V) – Limits (dB μ V) Q.P. =Quasi-Peak

AVG =average

12.1700

* is meaning the worst frequency has been tested in the frequency range 150 kHz to 30MHz.

50.00 -19.91

AVG

Limit: F	CC Part 15	C Conduct	ion(QP)		Pow	er: DC 5	Adapter In	put AC 120 V/ 60 Hz)
No. Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
	MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1	0.1580	40.25	10.10	50.35	65.57	-15.22	QP	
2	0.1580	15.70	10.10	25.80	55.57	-29.77	AVG	
3 *	0.1900	38.68	10.14	48.82	64.04	-15.22	QP	
4	0.1900	15.48	10.14	25.62	54.04	-28.42	AVG	
5	0.6740	27.41	9.30	36.71	56.00	-19.29	QP	
6	0.6740	14.25	9.30	23.55	46.00	-22.45	AVG	
7	2.1419	14.54	10.02	24.56	56.00	-31.44	QP	
8	2.1419	7.68	10.02	17.70	46.00	-28.30	AVG	
9	5.7179	18.24	10.12	28.36	60.00	-31.64	QP	
10	5.7179	12.52	10.12	22.64	50.00	-27.36	AVG	
11	12.2620	20.80	10.22	31.02	60.00	-28.98	QP	
12	12.2620	12.46	10.22	22.68	50.00	-27.32	AVG	

Note1:

Freq. = Emission frequency in MHz Reading level $(dB\mu V)$ = Receiver reading Corr. Factor (dB) = LISN factor + Cable loss Measurement $(dB\mu V)$ = Reading level $(dB\mu V)$ + Corr. Factor (dB)Limit $(dB\mu V)$ = Limit stated in standard

Margin (dB) = Measurement (dB μ V) – Limits (dB μ V)

Q.P. =Quasi-Peak

AVG =average

* is meaning the worst frequency has been tested in the frequency range 150 kHz to 30MHz.

Note2: Measurements were conducted in all three channels (high, middle, low), and the worst case Mode (Lowest channel) was submitted only.

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TCT 通测检测 TESTING CENTRE TECHNOLOGY Report No.: TCT240104E038 4.3. Maximum Radiated Output Power 4.3.1. Test Specification **Test Requirement:** FCC Part15 C Section 15.236 (d) **Test Method:** ANSI C63.10:2013 Limit: 20 mW EIRP 00 **Test Setup:** EUT Spectrum Analyzer **Test Mode:** Transmitting mode with modulation 1. The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement. **Test Procedure:** 2. Set to the maximum power setting and enable the EUT transmit continuously. 3. Measure the conducted output power and record the results in the test report. PASS **Test Result:**

4.3.2. Test Instruments

Equi	pment	Manufacturer	Model	Serial Number	Calibration Due	
Spectrun	n Analyzer	R&S	FSU	200054	Jun. 27, 2024	
					Page 11 of 36	6

4.3.3. Test Data

Frequency (MHz)	Conducted Output Power (dBm)	Antenna Gain	EIRP (dBm)	EIRP (mw)	EIRP Limit (mw)	Result
657.1	11.96	-3.75	8.21	6.62	20	PASS
659.5	11.90	-3.75	8.15	6.53	20	PASS
662.9	11.80	-3.75	8.05	6.38	20	PASS

Note: EIRP = Conducted Output Power + Antenna Gain

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FCT 通测检测 4.4. Occupied Bandwidt 4.4.1. Test Specification	Report No.: TCT240104E038
Test Requirement:	FCC Part15 C Section 15.236 (f)
Test Method:	ANSI C63.10:2013
Limit:	not exceed 200 kHz
Test Setup:	Spectrum Analyzer EUT
Test Mode:	Transmitting mode with modulation
Test Procedure:	 Set to the maximum power setting and enable the EUT transmit continuously. Make the measurement with the spectrum analyzer's resolution bandwidth (RBW) shall be in the range of 1% to 5% of the OBW, and VBW shall be approximately three times the RBW. The frequency span for the spectrum analyzer shall be between 1.5 times and 5.0 times the OBW. Use the 99% power bandwidth function and record the results in the test report.
Test Result:	PASS

4.4.2. Test Instruments

	RI	F Test Room	I	
Equipment	Manufacturer	Model	Serial Number	Calibration Due
Spectrum Analyzer	R&S	FSU	200054	Jun. 27, 2024

4.4.3. Test data

Frequency (MHz)	Occupy Bandwidth (kHz)	Limit (kHz)	Conclusion
657.1	60.74	200	PASS
659.5	60.74	200	PASS
662.9	60.74	200	PASS

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Č)	CT通测检测	 S. Measure the input level at the transmitter required to give +12 dB (lim). 6. The transmitter RF output spectrum shall be measured, using a spectrum analyser with the following settings: centre frequency: dispersion (Span): fc - 1 MHz to fc + 1 MHz; Resolution BandWidth (RBW): 1 kHz; Video BandWidth (VBW): 1 kHz; 	8
2	Test Result:	PASS	

4.5.2. Test Instruments

	RI	F Test Roon	า	
Equipment	Manufacturer	Model	Serial Number	Calibration Due
Spectrum Analyzer	R&S	FSU	200054	Jun. 27, 2024
Signal Generator	Agilent	N5182A	MY47420221	Jun. 28, 2024
)

4.6. Radiated Spurious Emission Measurement

4.6.1. Test Specification

TCT 通测检测 TESTING CENTRE TECHNOLOGY

Test Requirement:	FCC Part	15 (C Section 1	15.23	36 (ç	J)	
Test Method:	ANSI C63	3.10): 2013				
Frequency Range:	9 kHz to 2	2 GI	Hz	9			
Measurement Distance:	3 m						
Antenna Polarization:	Horizonta	8	Vertical				
Operation mode:	Transmitti	ing	mode with	mod	ulat	ion	
	Frequency	y	Detector	RB	W	VBW	Remark
	9kHz- 150k	Hz	Quasi-peak	200	Hz	1kHz	Quasi-peak Value
Receiver Setup:	150kHz-		Quasi-peak	9kH	Ηz	30kHz	Quasi-peak Value
Receiver Setup.	30MHz-1GI	Hz	Quasi-peak	1201	<hz_< td=""><td>300KHz</td><td>Quasi-peak Value</td></hz_<>	300KHz	Quasi-peak Value
		·	Peak	1M	Hz	3MHz	Peak Value
	Above iGi	ΗZ	Peak	1MI	Hz	10Hz	Average Value
		ĹC			Frec	uency	
		4	7 MHz to 74 M	lHz	Oth	er	Fraguencies
	State	87,	,5 MHz to 137	MHz	Free	quencies	ahove
Limit:		17	4 MHz to 230 I	MHz	belo	ow 1 000	1 000 MHz
	Oraration	47	0 MHz to 862 I	MHz	MH:	<u>Z</u>	4.11/
	Standby		2 n\//	97		250 five 2 n\//	20 n\//
	For radiated emissions below 30MHz						
Test setup:	Distance = 3m Computer Pre -Amplifier EUT EUT Turn table Ground Plane					Computer Amplifier Receiver	
	30MHz to	1G	ίΗz				
							Page 19 of 3

		me ma ant res abo 3. Corr Re 4. For of t low lev me det 5. Use (1) (2) (3) For dut whe the	asurement a eximizes the enna elevation tricted to a r ove the grou rected Read ad Level - P measureme the EUT measurement ver than the el will be rep easurement ver ethe followin Span shall ver emission be Set RBW=1 Sweep = au max hold; Set RBW = peak measur average measurement ver set not the solution contained to the solution the solution the solution the solution the solution the solution the solution the solution the solution the solution the solution the solution the solution	antenna elev emissions. ion for maxi ange of heig nd or refere ing: Antenna reamp Fact nt below 1G asured by th applicable li ported. Othe will be repea ported. g spectrum vide enough ing measure 20 kHz for f to; Detector 1 MHz, VBV trement. easurement o less than 9 e is less than ansmission	vation shall The measur mum emissi ghts of from nce ground a Factor + C or = Level Hz, If the en e peak dete mit, the pea rwise, the e ated using th analyzer se to fully cap ed; < 1 GHz; V function = p V= 3MHz fo 8 percent. N n 98 percer duration over	be that which rement ions shall be 1 m to 4 m plane. Cable Loss + mission level ector is 3 dB k emission me quasi-peak ttings: ture the BW \geq RBW; beak; Trace = r f >1 GHz fo Hz, when /BW \geq 1/T, of where T is er which the
		dut who the	en duty cycle minimum tr	e is less than 9 e is less tha ansmission	n 98 percent. N n 98 percer duration over	$VBW \ge 1/1,$ at where T is er which the
Test results	:	PASS	wer control l	evel for the	nsmitting at tested mode	its maximum e of operation
Test results		PASS	wer control le	n and is trar evel for the	nsmitting at tested mode	its maximum e of operation
Test results		PASS		evel for the	nsmitting at tested mode	its maximum e of operation
Test results		PASS		n and is traf	nsmitting at tested mode	its maximum e of operation
Test results		PASS		n and is tran	nsmitting at tested mode	its maximum e of operation

4.6.2. Test Instruments

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	Radiated En	nission Test Site	e (966)	
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
EMI Test Receiver	R&S	ESIB7	100197	Jun. 29, 2024
Spectrum Analyzer	R&S	FSQ40	200061	Jun. 29, 2024
Pre-amplifier	SKET	LNPA_0118G- 45	SK2021012 102	Jan. 31, 2025
Pre-amplifier	SKET	LNPA_1840G- 50	SK2021092 03500	Jan. 31, 2025
Pre-amplifier	HP	8447D	2727A05017	Jun. 27, 2024
Loop antenna	Schwarzbeck	FMZB1519B	00191	Jul. 02, 2024
Broadband Antenna	Schwarzbeck	VULB9163	340	Jul. 01, 2024
Horn Antenna	Schwarzbeck	BBHA 9120D	631	Jul. 01, 2024
Horn Antenna	Schwarzbeck	BBHA 9170	00956	Feb. 02, 2025
Antenna Mast	Keleto	RE-AM	1	1
Coaxial cable	SKET	RC-18G-N-M	1	Jan. 31, 2025
Coaxial cable	SKET	RC_40G-K-M	1	Jan. 31, 2025
EMI Test Software	Shurple Technology	EZ-EMC	16	/

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		Above 1GHz		
Frequency	Spurious Emission		Limit (dPm)	Recult
(MHz)	Polarization	Level (dBm)		Result
2628.792	V	-39.13)	
3286.002	V	-40.89		
			20.00	DASS
2628.792	H (KC)	-38.08	-30.00	PASS
3286.154	Н	-35.12		

Note:

- 1. The emission levels of other frequencies are very lower than the limit and not show in test report.
- 2. Measurements were conducted at the frequency range 25 MHz to 4 GHz for equipment operating on frequencies below 1 GHz.
- 3. Data of measurement shown "---"in the above table mean that the reading of emissions is attenuated more than 20 dB below the limits or the field strength is too small to be measured.
- 4. Measurements were conducted in all three channels (high, middle, low), and the worst case Mode (Lowest channel) was submitted only.

7.1. Test Specification						
Test Requirement:	FCC Part15 Section 15.	236 (f)(3)				
Test Method:	ANSI C63.10: 2013					
Limit:	The frequency tolerance maintained within ±0.00 over a temperature van degrees C at normal su in the primary supply v rated supply voltage at a	maintained within $\pm 0.005\%$ of the operating frequency over a temperature variation of -20 degrees to $+50$ degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to115% of the rated supply voltage at a temperature of 20 degrees C.				
		Temperature Chamber				
Test Setup:	Spectrum Analyzer	EUT				
	The FUT was placed	AC/DC Power supply	tes			
Test Procedure:	chamber and powered Turn the EUT on and o analyzer. c. Turn the EU highest temperature sp (approximately 30 min chamber to stabilize. e temperature chamber so The test chamber wa degree C for a minimi- voltage was then adju- 115% and the frequency	The EUT was placed inside the environmental test chamber and powered by nominal AC/DC voltage. b. Turn the EUT on and couple its output to a spectrum analyzer. c. Turn the EUT off and set the chamber to the highest temperature specified. d. Allow sufficient time (approximately 30 min) for the temperature of the chamber to stabilize. e. Repeat step 2 and 3 with the temperature chamber set to the lowest temperature. f. The test chamber was allowed to stabilize at +20 degree C for a minimum of 30 minutes. The supply voltage was then adjusted on the EUT from 85% to				
Test Result:	PASS					

4.7.2. Test Instruments

Equipment	Manufacturer	Model	Serial Number	Calibration Due
Spectrum Analyzer	ROHDE&SCH WARZ	FSQ40	200061	Jun. 29, 2024
Programable tempratuce and humidity chamber	JQ	JQ-2000	510101234	Jun. 28, 2024
DC power supply	Kingrang	KR3005K	/	Jun. 28, 2024

4.7.3. Test data

Test plots as follows: 657.1MHz

Temperature (°C)	Voltage (VDC)	Measurement Frequency (MHz)	Delta Frequency (Hz)	Limit (Hz)	Result
50		657.1062	6200	32855	PASS
40		657.1059	5900	32855	PASS
30	(\mathbf{C})	657.1063	6300	32855	PASS
20	2.7\/	657.1065	6500	32855	PASS
10	3.7 V	657.1077	7700	32855	PASS
0		657.1071	7100	32855	PASS
-10		657.1055	5500	32855	PASS
-20		657.1059	5900	32855	PASS
	3.3	657.1060	6000	32855	PASS
20	3.7	657.1068	6800	32855	PASS
	4.2	657.1067	6700	32855	PASS

Note: Limit(Hz)= 0.00005*Frequency(Hz)=0.00005*657.1*10⁶⁼32855(Hz)

659.5MHz

Temperature (°C)	Voltage (VDC)	Measurement Frequency (MHz)	Delta Frequency (Hz)	Limit (Hz)	Result
50		659.5061	6100	32975	PASS
40		659.5063	6300	32975	PASS
30		659.5069	6900	32975	PASS
20	- 3.7V	659.5070	7000	32975	PASS
10		659.5058	5800	32975	PASS
0		659.5074	7400	32975	PASS
-10		659.5075	7500	32975	PASS
-20		659.5068	6800	32975	PASS
	3.3	659.5057	5700	32975	PASS
20	3.7	659.5066	6600	32975	PASS
	4.2	659.5053	5300	32975	PASS

Note: Limit(Hz)= 0.00005*Frequency(Hz)=0.00005*659.5*10⁶⁼32975(Hz)

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Te	emperature (°C)	Voltage (VDC)	Measurement Frequency (MHz)	Delta Frequency (Hz)	Limit (Hz)	Result	
	50		662.9071	7100	33145	PASS	
	40		662.9079	7900	33145	PASS	
	30		662.9070	7000	33145	PASS	
	20	3 7\/	662.9069	6900	33145	PASS	
	10	0.7 V	662.9066	6600	33145	PASS	
< <u> </u>	0		662.9068	6800	33145	PASS	
	-10		662.9075	7500	33145	PASS	
	-20		662.9073	7300	33145	PASS	
	-	3.3	662.9081	8100	33145	PASS	
	20	3.7	662.9076	7600	33145	PASS	
	o: Limit/Uz)_	4.2	002.9003	0005*662 0*10 ⁶⁼	33143 =22145(U-)	PASS	

